

General Description

SFGMOS[®] 8: 10 T M L PO ZY: PYLW PX NZ Y T P OPaTP OP TRY Z LNSPaP low $R_{DS(ON)}$, low gate charge, fast switching and excellent avalanche characteristics. The low V_{th} series is specially designed to use in synchronous rectification applications with low driving voltage.

Features

- Low $R_{DS(ON)}$

Absolute Maximum Ratings at $T_j=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Value	Unit
Drain source voltage	V_{DS}	100	V
Gate source voltage	V_{GS}	± 20	V
Continuous drain current ¹⁾ , $T_C=25^\circ\text{C}$	I_D	60	A
Pulsed drain current ²⁾ , $T_C=25^\circ\text{C}$	$I_{D,\text{pulse}}$	180	A
Continuous diode forward current ¹⁾ , $T_C=25^\circ\text{C}$	I_S	60	A
Diode pulsed current ²⁾ , $T_C=25^\circ\text{C}$	$I_{S,\text{Pulse}}$	180	A
Power dissipation ³⁾ , $T_C=25^\circ\text{C}$	P_D	107	W
Single pulsed avalanche energy ⁵⁾	E_{AS}	65	mJ
Operation and storage temperature	$T_{stg} \quad T_j$	-55 to 150	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal resistance, junction-case	$R_{j\text{-case}}$	1.17	$^\circ\text{C/W}$
Thermal resistance, junction-ambient ⁴⁾	$R_{j\text{-amb}}$	62	$^\circ\text{C/W}$

Electrical Characteristics at $T_j=25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Drain-source breakdown voltage	BV_{DSS}	100			V	$V_{GS}=0 \text{ V}, I_D=250 \text{ A}$
Gate threshold voltage	$V_{GS(\text{th})}$	1.5		2.5	V	$V_{DS}=V_{GS}, I_D=250 \text{ A}$
Drain-source on-state resistance	$R_{DS(\text{ON})}$		9	10	X	$V_{GS}=10 \text{ V}, I_D=30 \text{ A}$
Drain-source on-state resistance	$R_{DS(\text{ON})}$		12	14	X	$V_{GS}=4.5 \text{ V}, I_D=12 \text{ A}$
Gate-source leakage current	I_{GSS}			100	nA	$V_{GS}=20 \text{ V}$
				-100		$V_{GS}=-20 \text{ V}$
Drain-source leakage current	I_{DSS}			1	A	$V_{DS}=100 \text{ V}, V_{GS}=0 \text{ V}$
Gate resistance	R_G		5.5			(83e : PYOLTY)

Dynamic Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Input capacitance	C _{iss}		1998		pF	V _{GS} =0 V, V _{DS} =50 V, (kHz)
Output capacitance	C _{oss}		322		pF	

Reverse transfer8001f444d276.c



Electrical Characteristics Diagrams

Figure 1. Typ. output characteristics	Figure 2. Typ. transfer characteristics
Figure 3. Typ. capacitances	Figure 4. Typ. gate charge
Figure 5. Drain-	

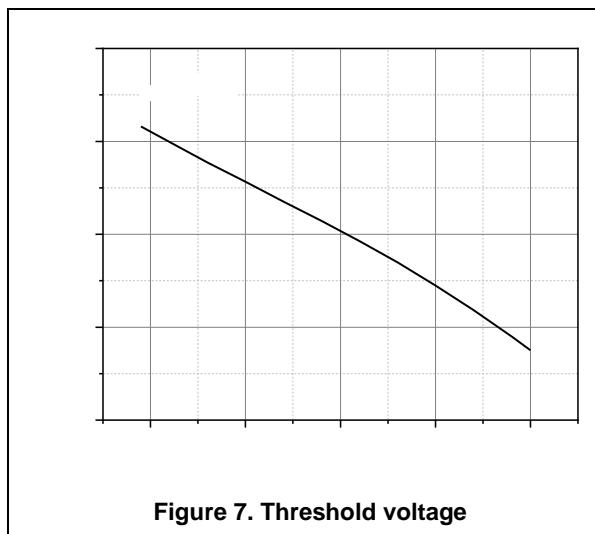


Figure 7. Threshold voltage

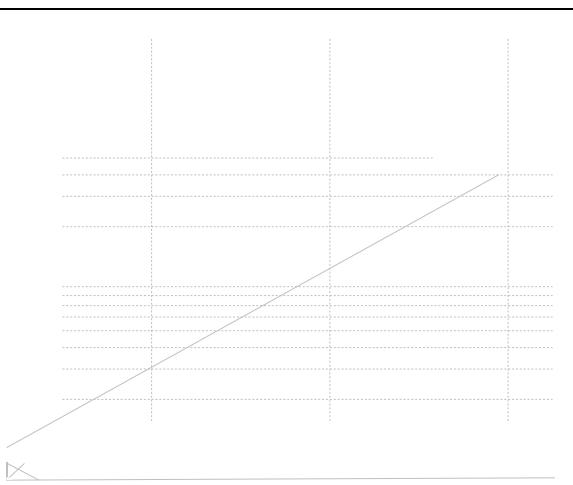


Figure 8. Forward characteristic of body diode

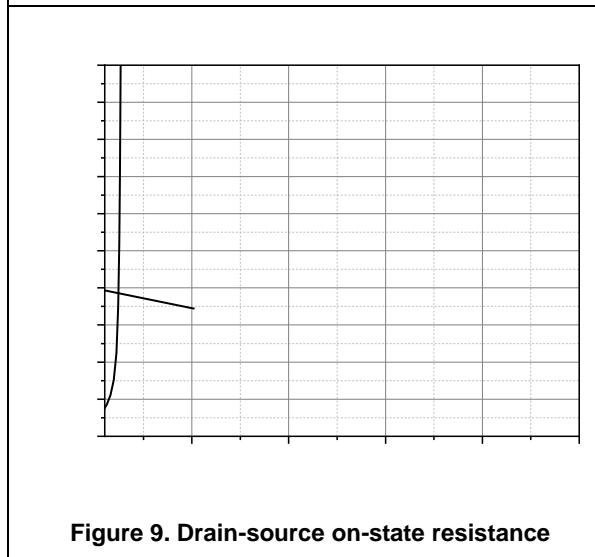


Figure 9. Drain-source on-state resistance

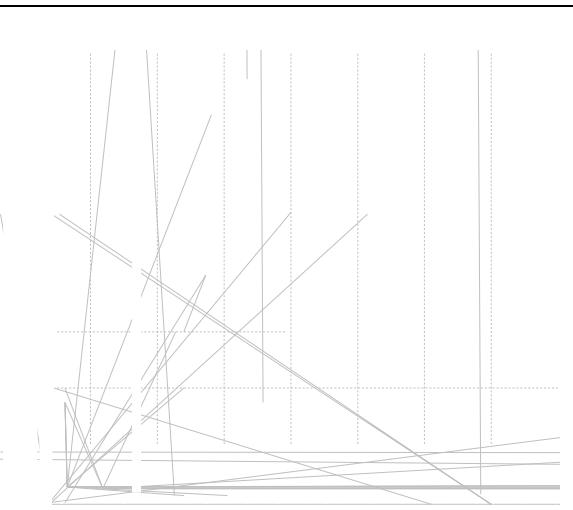


Figure 10. Drain current

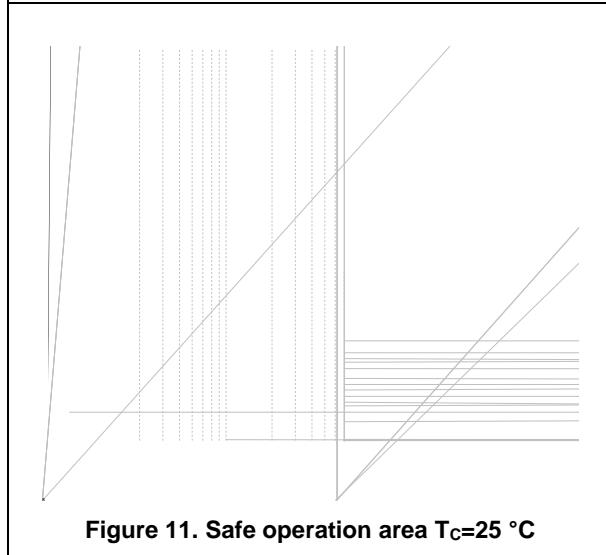


Figure 11. Safe operation area $T_c=25^\circ\text{C}$

Test circuits and waveforms

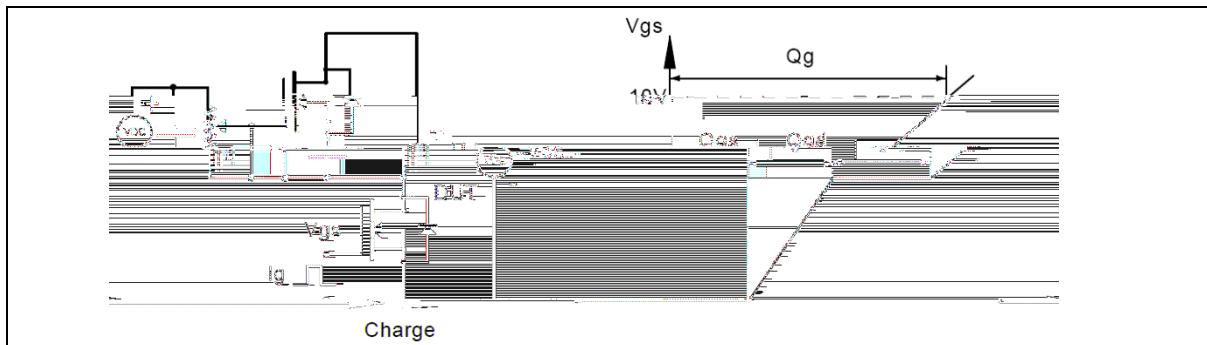


Figure 1. Gate charge test circuit & waveform

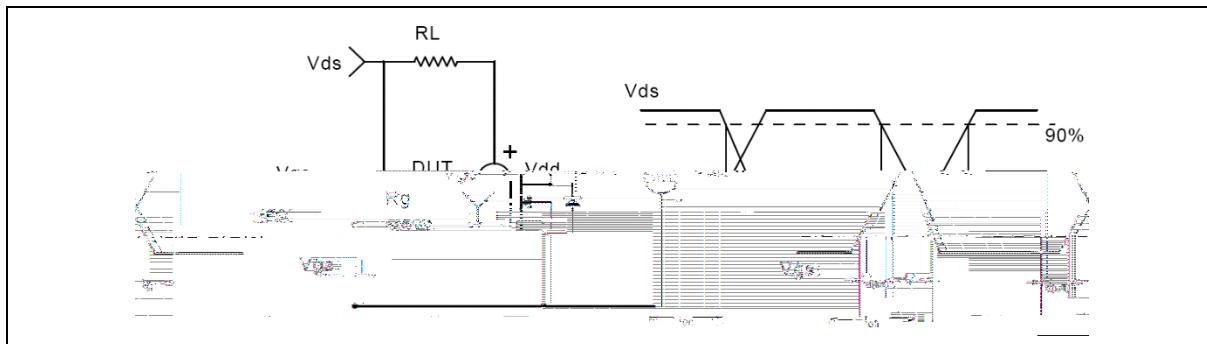


Figure 2. Switching time test circuit & waveform

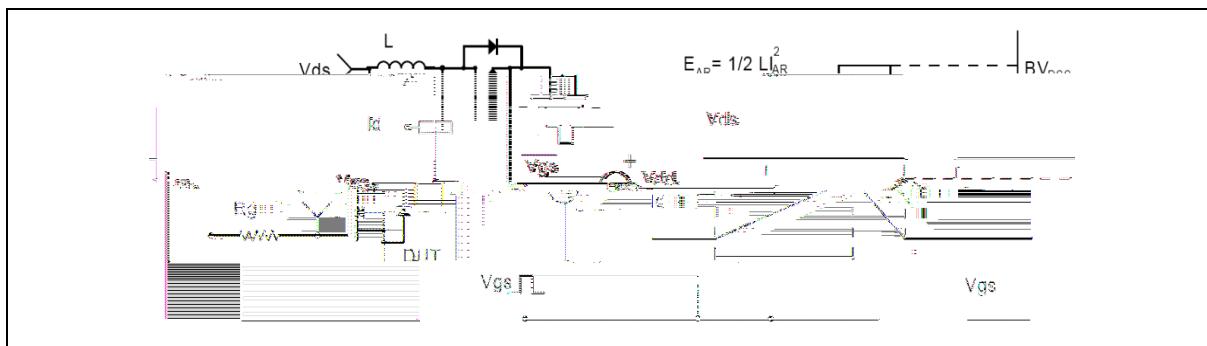


Figure 3. Unclamped inductive switching (UIS) test circuit & waveform

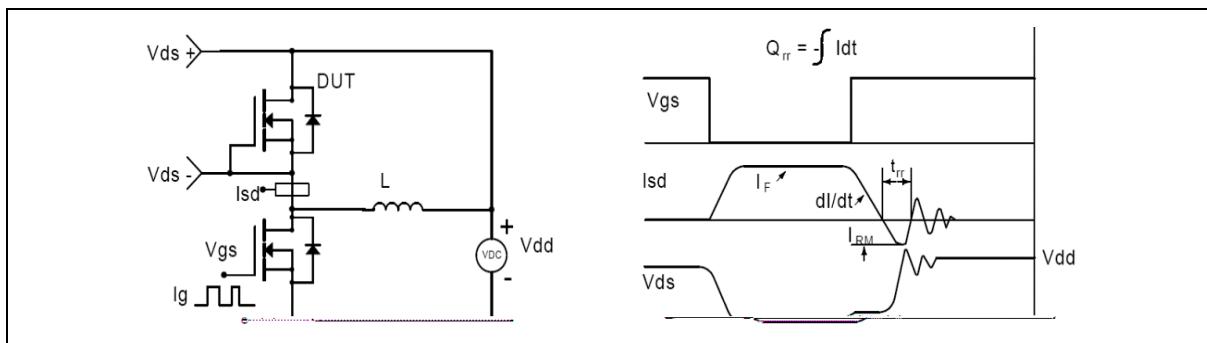


Figure 4. Diode reverse recovery test circuit & waveform

Package Information

Symbol	mm		
	Min	Nom	Max
A	4.40	4.50	4.60
A1	1.27	1.30	1.

Ordering Information

Package Type	Units/Tube	Tubes / Inner Box	Units/ Inner Box	Inner Boxes/ Carton Box	Units/ Carton Box
TO220-J	50	20	1000	5	5000

Product Information

Product	Package	Pb Free	RoHS	Halogen Free
SFG10S10PF	TO220	yes	yes	yes

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